

**Measurement of the B^- and \bar{B}^0 meson Lifetimes
using Semileptonic Decays with Single Lepton Datasets
in CDF Run II
(CDF 7458)**

Feb-3 2005 Preblessing Talk @ B meeting
S. Uozumi, F. Ukegawa

- 1. Introduction**
- 2. Analysis overview**
- 3. Event selection & B vertex reconstruction**
- 4. Missing momentum correction (K factor)**
- 5. Combinatorial background modeling**
- 6. Resolution scale factor**
- 7. Physics background**
- 8. Sample composition**
- 9. Lifetime fit results**
- 10. Systematic uncertainties**
- 11. Summary**

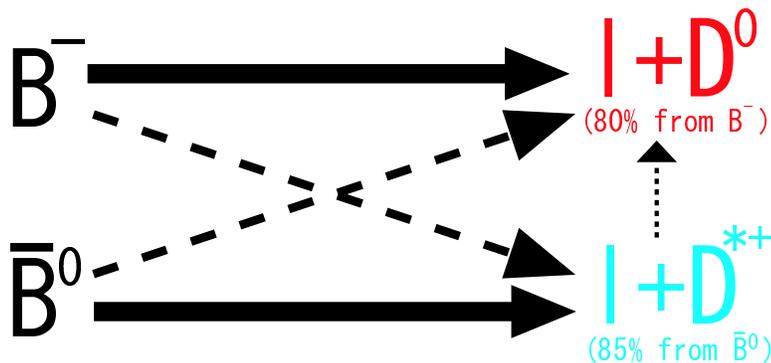
Introduction

Why measuring lifetime is important?

- Test HQE model (Heavy Quark Expansion, by I.I. Bigi)
It involves non-spectator effects. The HQE predicts :
 - $\tau(B^+)/\tau(\bar{B}^0) \sim 1 + 0.05(f_B/200 \text{ MeV})^2$
 - $\tau(B_s)/\tau(\bar{B}^0) \sim 1 \pm 0.01$
- An unavoidable step to measure $c\tau(\bar{B}_s^0)$, $\Delta\Gamma(\bar{B}_s^0)$, and $B_s^0\bar{B}_s^0$ oscillation with semileptonics.

B^-/\bar{B}^0 lifetime measurement using semileptonics

- Use $B^-/\bar{B}^0 \rightarrow \ell^- \bar{\nu} D^0 X$ ($\ell^- = e^-$ or μ^-),
 $D^0 \rightarrow K^- \pi^+$
- Large branching fraction
- Charge correlation is useful to identify the B signal
($Q_\ell = Q_K$)
- Decay chains are somewhat complicated, but can be disentangled by separating $\ell^- D^{*+}$ candidates



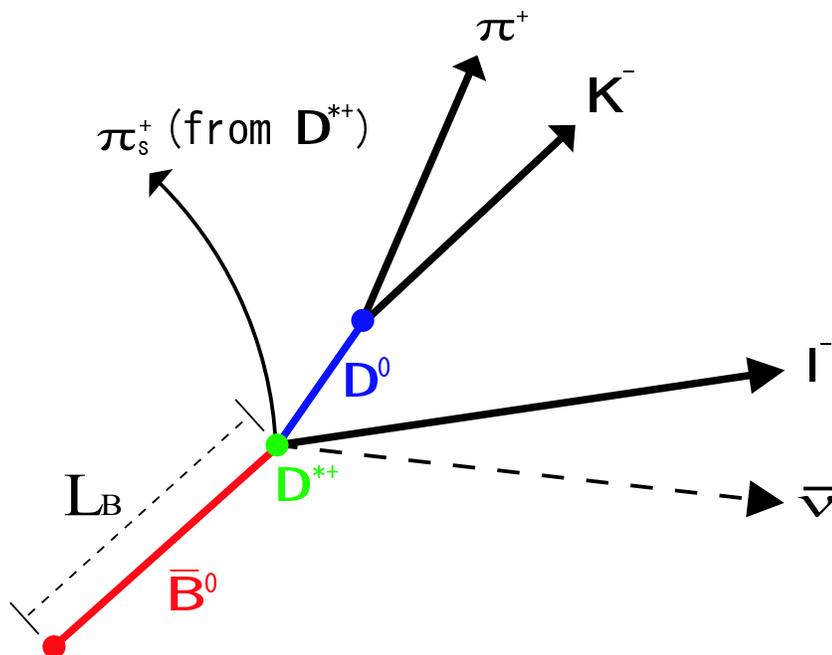
Analysis outline

1. Select a lepton (e or μ) from 8 GeV lepton datasets
2. Reconstruct $D^0 \rightarrow K^- \pi^+$ around the lepton
3. Find $D^{*+} \rightarrow D^0 \pi_s^+$ candidates, and split them from the $\ell^- D^0$ sample
4. Reconstruct $\bar{B} \rightarrow \ell^- \bar{\nu} D^0 X$ decay vertex in xy plane, and calculate B pseudo decay time
5. Correct missing momentum (K factor)
 - $p_T(B)$ can not be reconstructed due to some missing particles (neutrino, particles from $D^{*,**}$)
 - Correct it using MC
6. Model combinatorial background shape
 - use $D^0(D^{*+})$ mass sideband
7. Determine resolution scale factor
8. Estimate physics backgrounds
 - Prompt charm background
 - Bottom background
9. Estimate sample composition
 - Need to know B^-/\bar{B}^0 composition in each $\ell^- D^0$ and $\ell^- D^{*+}$ sample
10. Extract the lifetimes using unbinned likelihood fit
11. Estimate systematic uncertainties

Dataset & Reconstruction

- 8 GeV lepton trigger ..require μ, e with $p_T > 8 \text{ GeV}/c$
- Minimal trigger bias
- 260 pb^{-1} of the data used for this analysis
(electron trigger is dynamically prescaled)

Reconstruction of the B decay vertex in xy plane :
(typical case)



pseudo decay time is calculated as

$$ct^* = \frac{L_B}{p_T(\ell^- D^0)} M_B$$

Event selection

- Muon selection:

- $p_T(\mu) > 8 \text{ GeV}/c$
- $\chi_x^2(\text{CMU, CMP}) < 6, \chi_z^2(\text{CMU}) < 5$
- $\text{Iso}(\Sigma E_T \text{ in } \Delta R < 0.4)/p_T(D^0) < 2.5$

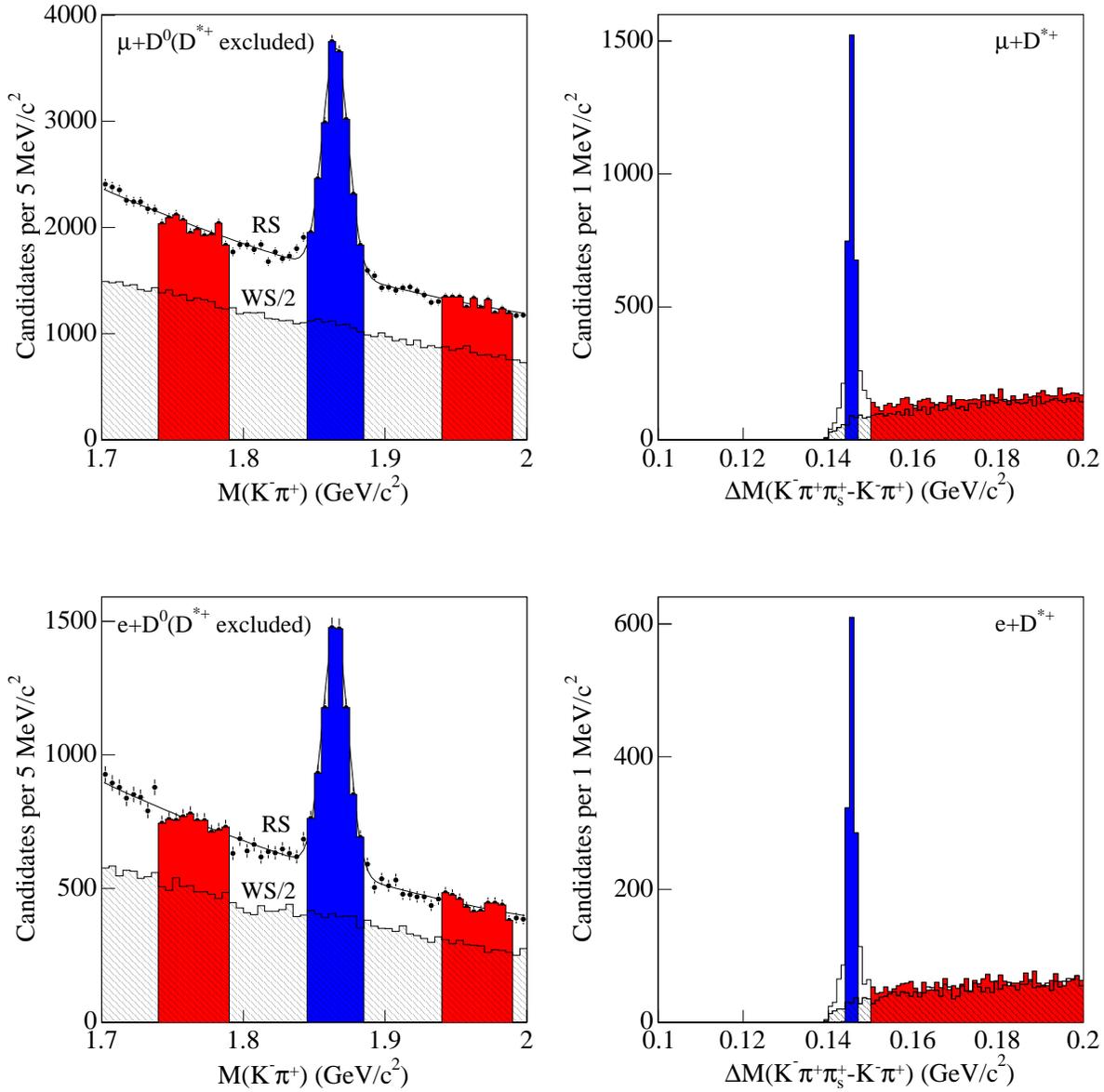
- Electron selection:

- $p_T > 8 \text{ GeV}/c, E_T > 8 \text{ GeV}/c^2$
- Reconstructed in CEM fiducial region.
- LSHR < 0.2
- CES $|\Delta x| < 1.4 \text{ cm}$
- CES $|\Delta z \sin \theta| < 2 \text{ cm}$
- CES $\chi_x^2, \chi_z^2 < 15$
- $E_{\text{HAD}}/E_{\text{EM}} < 0.04$ (if # of associated track = 1)
- $E_{\text{HAD}}/E_{\text{EM}} < 0.1$ (if # of associated track > 1)
- $0.75 < E/p < 1.4$
- Conversion Removal :
 - * $|S| < 0.2 \text{ cm}$
 - * $|\Delta \cot \theta| < 0.06$

Event selection (cont'd)

- For $D^0 \rightarrow K^- \pi^+$ and $D^{*+} \rightarrow D^0 \pi_s^+$ reconstruction:
 - # of COT axial(stereo) hits $\geq 20(16)$ (for ℓ, K, π)
 - # of SVXII $r\phi$ hits ≥ 3 (for ℓ, K, π, π_s)
 - $|\Delta z_0(\ell - K, \pi)| < 1.25$ cm
 - $p_T(K) > 1.5$ GeV/ c , $p_T(\pi) > 0.5$ GeV/ c
 - $\Delta R(\ell - K) < 0.6$, $\Delta R(\ell - \pi) < 0.7$
 - $M(\ell^- D^0) < 5.3$ GeV/ c^2
 - $L_{xy}(D^0 - P.V.) > 0$
 - $|ct(D^0)| < 0.1$ cm
 - $-0.15 < ct^*(B) < 0.3$ cm
 - $\sigma_{ct^*}(B), \sigma_{ct}(D^0) < 0.02$ cm

$\ell^- D^0(D^{*+})$ signal



	$N_{D^0} (D^{*+})$	Signal fraction
$\mu^- D^0$	9338	0.425 ± 0.004
$\mu^- D^{*+}$	2673	0.907 ± 0.007
$e^- D^0$	4022	0.471 ± 0.007
$e^- D^{*+}$	1107	0.908 ± 0.010

B monte carlo samples

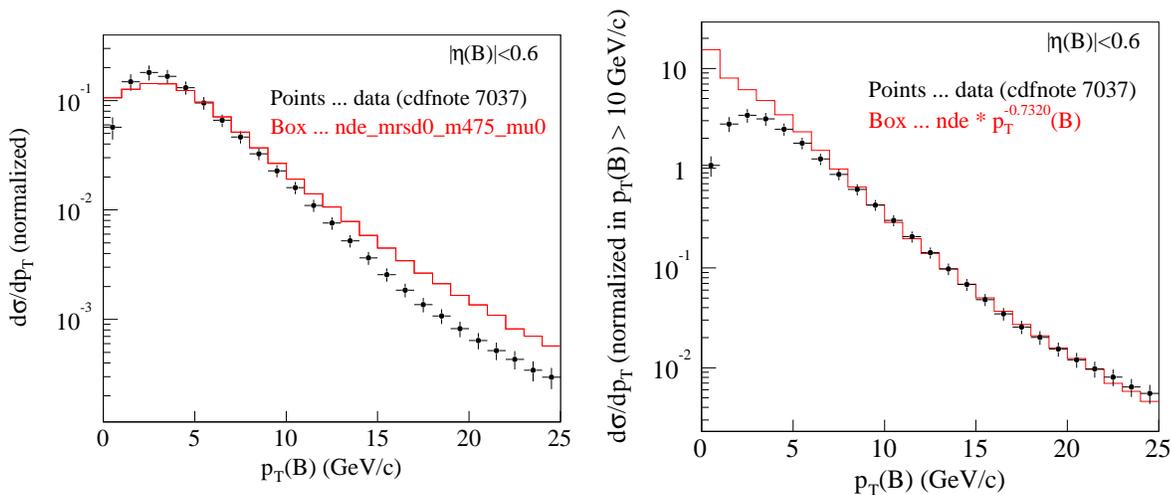
Monte carlo samples are indispensable for this analysis. B signal monte carlo samples are generated with Bgenerator + QQ .

We have two type of MC samples:

- parametric MC sample ... keep only generator-level information. Much statistics, used to calculate muon K factors
- full simulation sample ... apply full simulation, used for electron K factor calculation, and sample composition estimation both muon and electron datasets.

Tuning on the $p_T(B)$:

$p_T(B)$ spectrum used in the Bgenerator have somewhat different shape from the real spectrum measured by J/ψ data (cdf7037). We correct the difference by weighting the MC events with a factor of $p_T(B)^{-0.7320}$.



Missing momentum correction (K factor)

“Real” decay time of a B meson :

$$ct = \frac{L_B}{p_T(B)} M_B$$

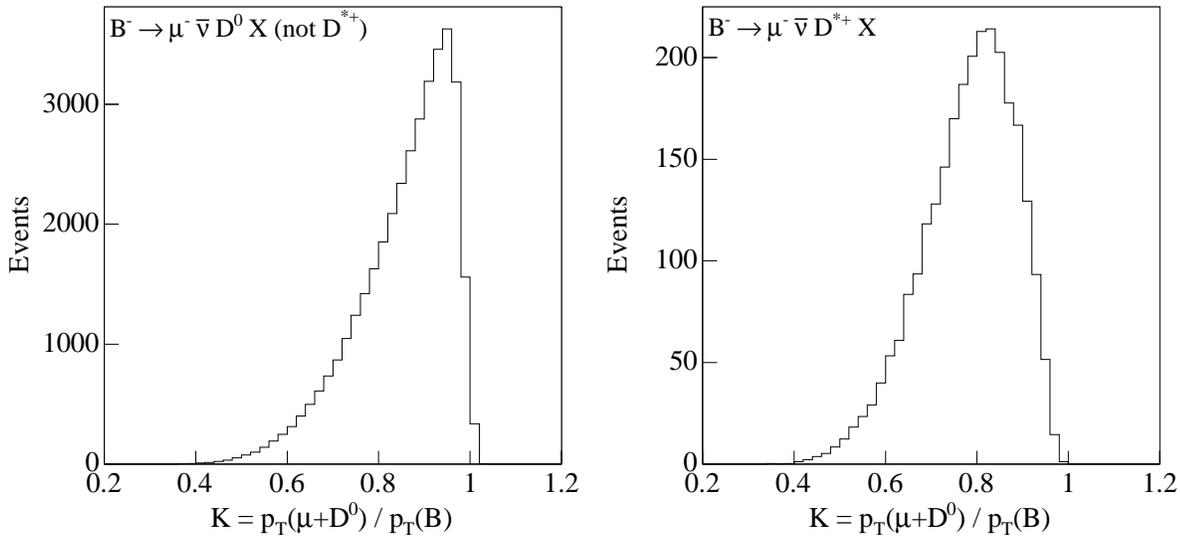
But since the B is not fully reconstructed, what we can measure is $P_T(\ell^- D^0)$ and “pseudo” decay time ct^* .

$$ct^* = \frac{L_B}{p_T(\ell^- D^0)} M_B = ct \cdot K \quad \text{where } K \equiv \frac{p_T(\ell^- D^0)}{p_T(B)}$$

From the distributions of both ct^* (data) and K factor, we can extract the lifetime of “true” decay time.

The K factor distributions are obtained from the B monte carlo samples.

Totally 8 K distributions are prepared for the lifetime fit. ($\bar{B} \rightarrow \ell^- \bar{\nu} D X$, $\bar{B} = B^- / \bar{B}^0$, $\ell = \mu / e$, $D = D^0 / D^{*+}$)



Combinatorial background modeling

The shape of the combinatorial background is taken from the $M(D^0)$ (or ΔM) sideband events.

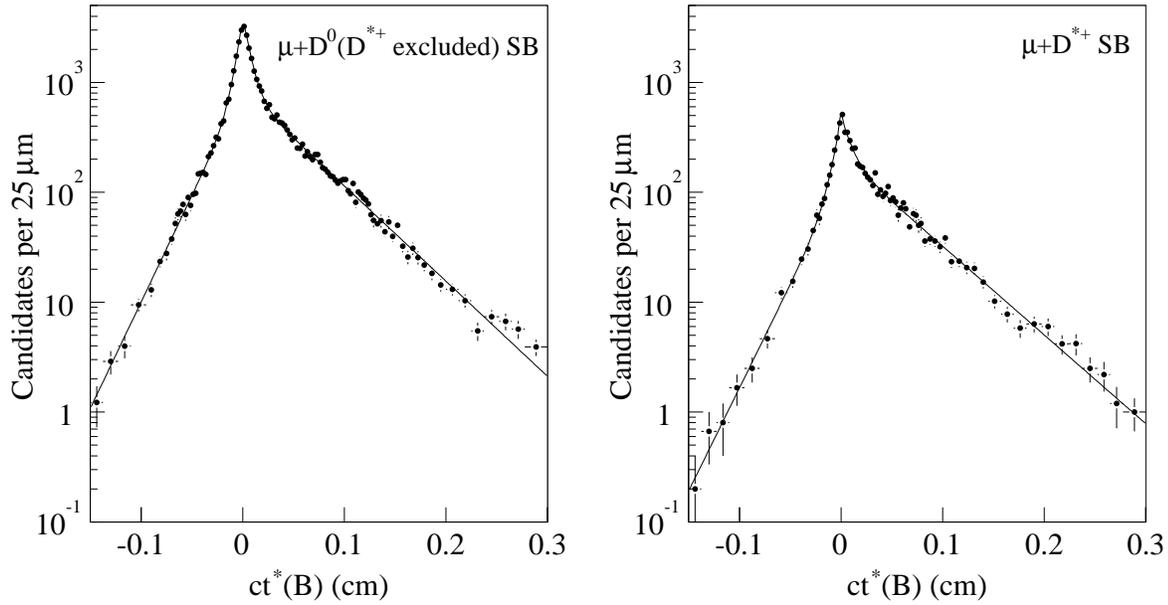
The sideband events are modeled with following background function:

$$\begin{aligned} \mathcal{F}_{BG}(ct^*) = & (1 - f_{1+} - f_{2+} - f_{1-} - f_{2-}) G(ct^*; \sigma) \\ & + \{f_{1+} \text{Exp}(-x; \lambda_{1+}) + f_{2+} \text{Exp}(-x; \lambda_{2+})\} \theta(x) \otimes G(\sigma) \\ & + \{f_{1-} \text{Exp}(+x; \lambda_{1-}) + f_{2-} \text{Exp}(+x; \lambda_{2-})\} \theta(-x) \otimes G(\sigma) \end{aligned}$$

where $G(ct^*; \sigma)$ is a normalized Gaussian,

$\theta(x)$ is step function (0 for $x > 0$, 1 for $x < 0$).

Fit results (only μ results are shown here):



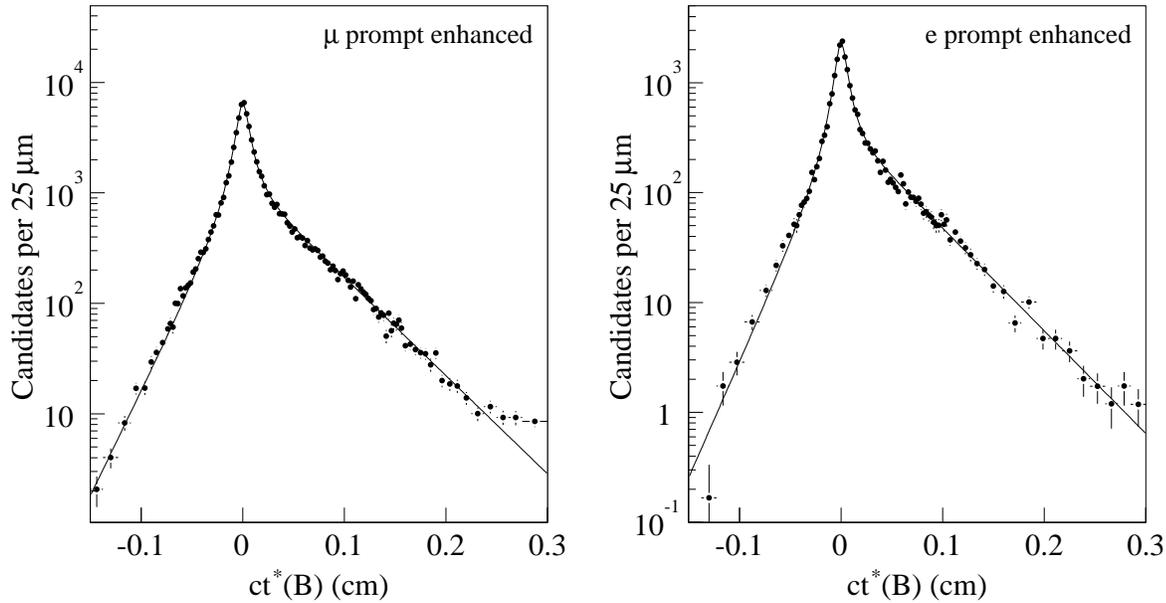
The background shapes under the signal peak are defined by these fits.

Resolution scale factor

The value of σ_{ct^*} provided by CTVMFT is NOT known to be a right resolution. To correct it, we introduce a resolution scale factor s , and scale the σ_{ct^*} to $s\sigma_{ct^*}$.

To determine the scale factor, we use a “prompt enhanced sample” selected by loosening the lepton ID cuts. From this sample, we pick sideband events and fit the ct^* distribution with the following likelihood function

$$\begin{aligned} \mathcal{F}_{\text{prompt}} = & G(ct^*, s\sigma_{ct^*}) \\ & + f_+ \text{Exp}(-ct^*; \lambda_+) \theta(x) \otimes G(s\sigma_{ct^*}) \\ & + f_- \text{Exp}(+ct^*; \lambda_-) \theta(-x) \otimes G(s\sigma_{ct^*}) \end{aligned}$$



The scale factors are found to be

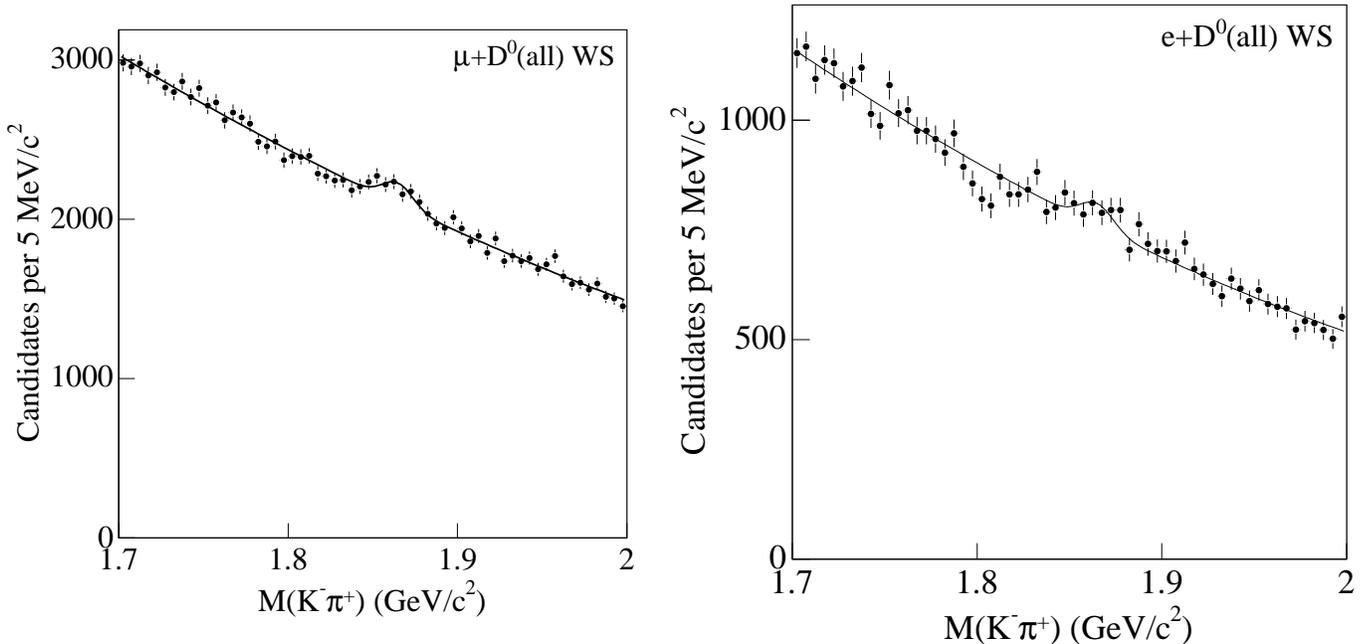
$$s = \begin{cases} 1.52 \pm 0.01 & \text{for muon} \\ 1.45 \pm 0.02 & \text{for electron} \end{cases}$$

Physics background

Physics background \equiv events which are observed as $\ell^- D^0$, but not the semileptonic B^- / \bar{B}^0 decays.

Clue of the physics background:

There are small peaks observed in the Wrong-Sign combination events ($\ell^+ D^0$).



$$N_{D^0}(WS) = \begin{cases} 677.7 \pm 141.7 & (5.6 \pm 1.2\% \text{ of RS}) \text{ for muon} \\ 262.7 \pm 85.3 & (5.0 \pm 1.6\% \text{ of RS}) \text{ for electron} \end{cases}$$

These events should come from:

(assuming the leptons could be fakes)

1. Prompt D^0 + track from P.V.
2. bottom background ($\bar{b}b \rightarrow \ell^+ D^0$, etc..)

And same kind of physics backgrounds may exist also in the RS peak.

Charm background

Following prompt charm events give the RS track+ D^0 combinations.

1. $c \rightarrow D^0 + \text{prompt track}$
2. $c\bar{c}, c \rightarrow D^0, \bar{c} \rightarrow \text{track} + X$

We need to measure the fraction of the prompt charm backgrounds from the RS data sample.

Since it is difficult to distinguish them using any kinematic quantities, we utilize a decay length information to estimate the prompt charm fraction.

We define following variable:

$$ct_2 = \frac{L_{xy}(D^0 - P.V.)}{p_T(K^-\pi^+)} M(K^-\pi^+)$$

- If the D^0 is generated at P.V. (namely prompt charm), the mean lifetime of ct_2 should be same with $c\tau(D^0) = 123 \mu\text{m}$.
- If the event is secondary charm from B decays, the lifetime will be much longer. (Convolution of two exponentials)

Charm background (cont'd)

Idea : fit the ct_2 distribution with following templates, and measure the charm fraction f_c in each sample.

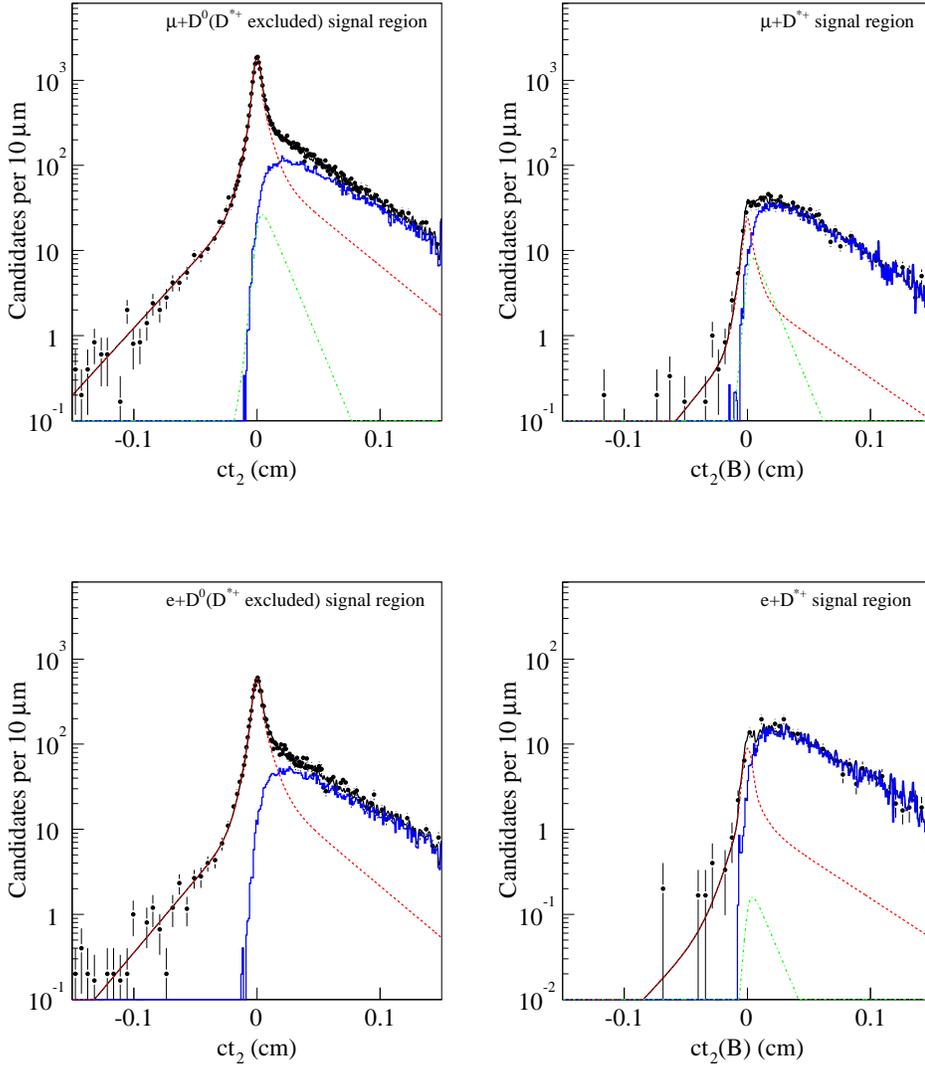
- Charm component (F_c) ... exponential with $c\tau = 123 \mu\text{m}$, smeared by resolution
- B component (F_B) ... shape obtained from B full simulation sample, smeared with proper resolution
- combinatorial BG (F_{BG}) ... shape taken from the side-band events

Likelihood function :

$$F = f_{\text{sig}}(f_c F_c + (1 - f_c) F_B) + (1 - f_{\text{sig}}) F_{\text{BG}}$$

The $L_{xy} > 0$ cut is disabled at the f_c fit.

Fit for prompt charm fraction



$$f_c = \frac{N_c}{N_{D^0}} = \begin{cases} 5.7 \pm 1.2\% & \text{for } \mu + D^0 (D^{*+} \text{ excluded}) \text{ sample} \\ 5.8 \pm 1.3\% & \text{for } \mu + D^{*+} \text{ sample} \\ 0.0^{+2.0\%}_{-0.0\%} & \text{for } e + D^0 (D^{*+} \text{ excluded}) \text{ sample} \\ 0.3^{+1.9\%}_{-0.3\%} & \text{for } e + D^{*+} \text{ sample} \end{cases}$$

The small f_c in electron dataset is not fully understood, presumably some electron ID cuts might have suppressed the prompt charms.

ct^* shape of the charm background

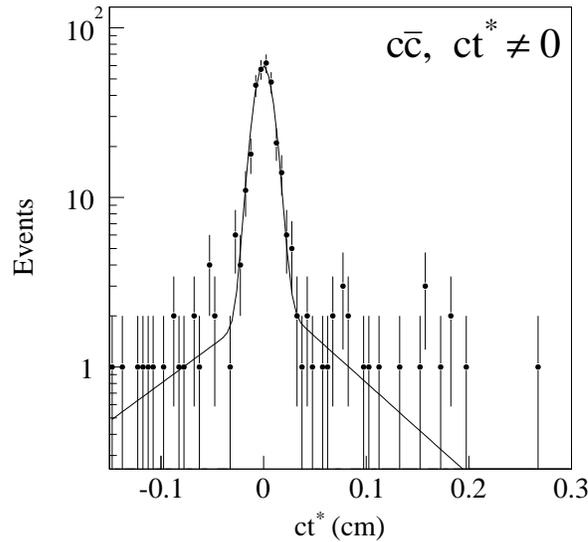
We can categorize prompt charm backgrounds into following two types:

1. $ct^* = 0$ events .. both D^0 and track are from the P.V.
2. $ct^* \neq 0$ events ... $c\bar{c}$ event, track is from a pseudo-scalar \bar{D} hadron

For the $ct^* = 0$ events, the ct^* shape is given by Gaussian,

$$\mathcal{F}_c^{\text{zero}} = G(ct^*; s\sigma_{ct^*})$$

For the $ct^* \neq 0$, we use pythia $c\bar{c}$ MC to calculate the ct^* shape $\mathcal{F}_c^{\text{non-zero}}$.



In the final lifetime fit we use the $\mathcal{F}_c^{\text{zero}}$ as the charm background shape \mathcal{F}_c . The $\mathcal{F}_c^{\text{non-zero}}$ is used for evaluation of the systematic uncertainties.

Bottom background

We use $b\bar{b}$ monte carlo by Pythia + QQ to estimate the effect of the bottom background. Since branching fractions of various B decay processes are measured by many experiments and are implemented to QQ, we can calculate bottom background fraction against the B semileptonic signals reliably from the $b\bar{b}$ monte carlo.

Breakdown of the $b\bar{b} \rightarrow \ell^- D^0$ MC processes
(by Pythia + QQ, no detector simulation):

process	$\ell^- D^0$ (D^{*+} excluded)	$\ell^- D^{*+}$
Semileptonic $\ell^- D^0$	5226	2702
non-semileptonic $\ell^- D^0$	217	108
$\bar{B}_s^0 \rightarrow \ell^- \bar{\nu} D_s^{*+}, D_s^{*+} \rightarrow D^0 X$	84	50
$\bar{B} \rightarrow \tau^- \bar{\nu} D^0, \tau^- \rightarrow \ell^- \bar{\nu}$	52	27
$\bar{B} \rightarrow D^0 D_s^- X, D_s^- \rightarrow \ell^- X'$	46	8
$\bar{B} \rightarrow D^0 D_s^- X, D_s^- \rightarrow \tau^- X', \tau^- \rightarrow \ell^- X''$	18	5
$\bar{B} \rightarrow D \bar{D} X \rightarrow \ell^- D^0 X'$	7	6
$b\bar{b}, b \rightarrow D^0 X, \bar{b} \rightarrow \ell^+ X',$ (b or \bar{b} oscillates and give RS)	6	8
$b\bar{b}, b \rightarrow D^0 X, \bar{b} \rightarrow \bar{c} \rightarrow \ell^- X'$	2	1
others	2	3
hadron+ D^0	3371	2138
single $b \rightarrow h^- D^0$	3308	2117
$b\bar{b} \rightarrow h^- D^0$	63	21

From the table, we obtain the bottom BG fraction

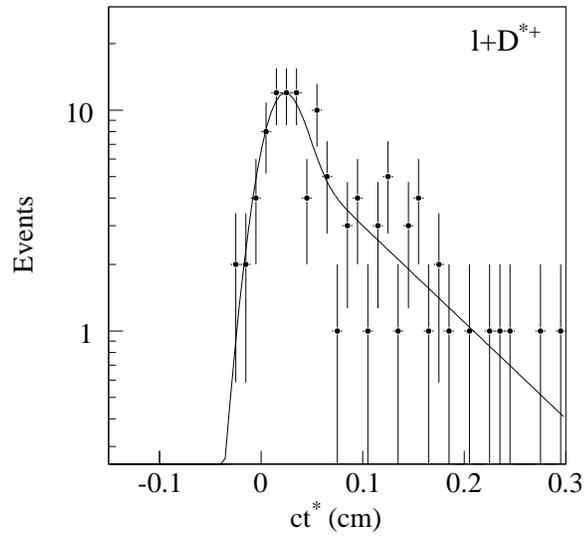
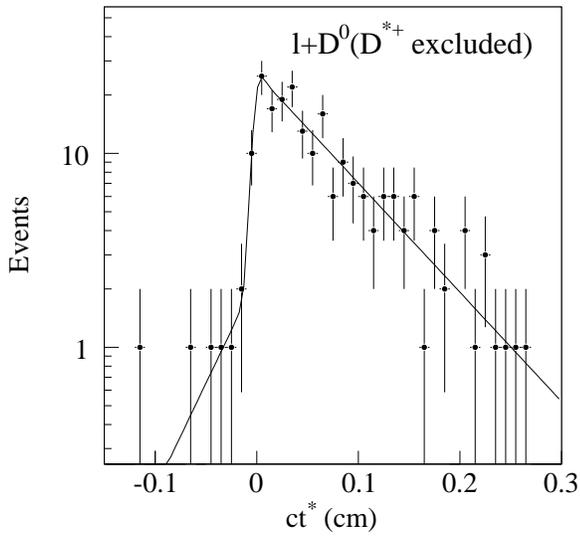
$$f_b = \frac{N_b}{N_{D^0}} = \begin{cases} 3.8 \pm 0.3\% & \text{for } \mu + D^0 (D^{*+} \text{ excluded}) \\ 3.6 \pm 0.4\% & \text{for } \mu + D^{*+} \\ 4.0 \pm 0.3\% & \text{for } e + D^0 (D^{*+} \text{ excluded}) \\ 3.8 \pm 0.4\% & \text{for } e + D^{*+} \end{cases}$$

Bottom background (cont'd)

From the non-semileptonic $\ell^- D^0$ events in the $b\bar{b}$ monte carlo sample, we get shapes of the bottom backgrounds.

We fit these distributions with following function:

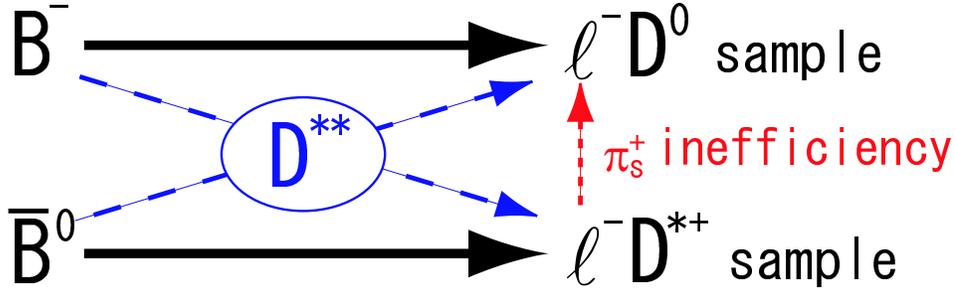
$$\begin{aligned}\mathcal{F}_b = & (1 - f_+ - f_-)G(ct^* - \alpha; \sigma) \\ & + f_+ \text{Exp}(-ct^*; \lambda_+) \theta(x) \otimes G(\sigma) \\ & + f_- \text{Exp}(+ct^*; \lambda_-) \theta(-x) \otimes G(\sigma)\end{aligned}$$



The \mathcal{F}_b is used as the bottom background shape in the final lifetime fit.

Sample composition

For the lifetime fit, we need to know B^-/\bar{B}^0 composition each in $\ell^- D^0$ (D^{*+} excluded) and $\ell^- D^{*+}$ sample.



There are two causes of the cross talks.

1. Semileptonic B decays through D^{**} states

Following decays through D^{**} cause cross talks of B^-/\bar{B}^0 components.

$$B^- \rightarrow \ell^- \bar{\nu} D^{**0}, D^{**0} \rightarrow D^{*+} \pi^+$$

$$\bar{B}^0 \rightarrow \ell^- \bar{\nu} D^{**+}, D^{**+} \rightarrow D^0 \pi^-$$

$$\bar{B}^0 \rightarrow \ell^- \bar{\nu} D^{**+}, D^{**+} \rightarrow D^{*0} \pi^-, D^{*0} \rightarrow D^0 X^0$$

We utilize the full simulation sample to estimate these cross talks.

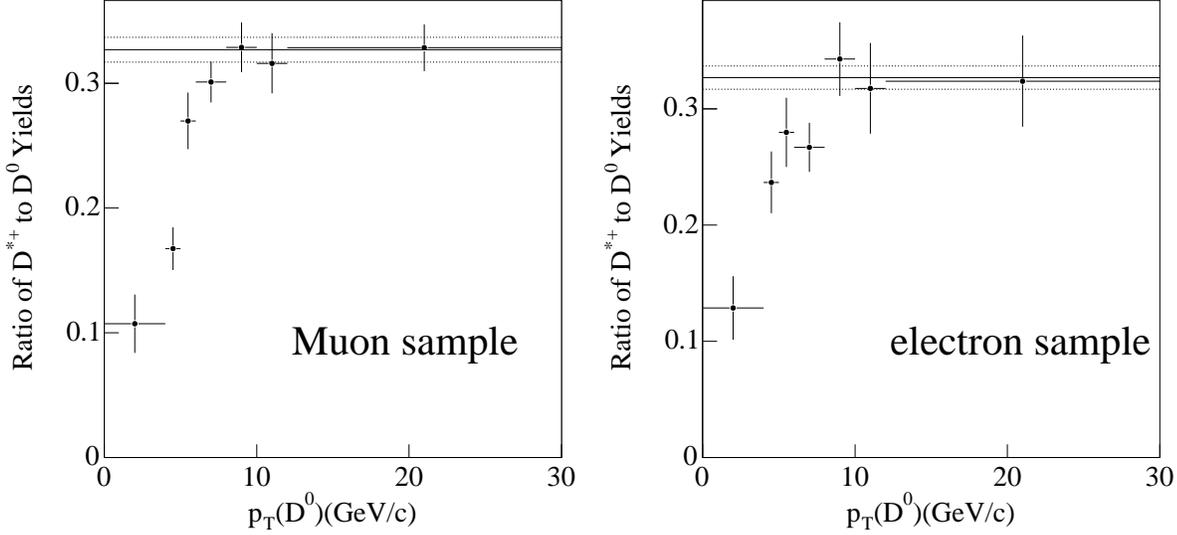
2. Inefficiency of π_s^+ reconstruction

The slow pions from $D^{*+} \rightarrow D^0 \pi_s^+$ decays have low p_T , where the COT tracking efficiency is not perfect. It causes a cross talk from D^{*+} to D^0 sample.

Considering these effects, we estimate B^- fraction g_- in each sample.

Sample composition (cont'd)

We measure the slow pion efficiency from the ratio of D^{*+}/D^0 yields against $p_T(D^0)$.



We divide the samples into plateau ($p_T(D^0) > 8 \text{ GeV}/c$) and low $p_T(D^0)$ regions.

Assuming that in the plateau region π_s^+ tracking efficiency is 99.6% (from cdfnote 6314), $\epsilon(\pi_s^+)$ values in each sample are calculated as follows.

Dataset	$p_T(D^0)$ region	D^{*+}/D^0 ratio	$\epsilon(\pi_s^+)$
Muon	$< 8 \text{ GeV}/c$	0.221 ± 0.010	0.673 ± 0.037
	$> 8 \text{ GeV}/c$	0.326 ± 0.012	$0.993^{+0.007}_{-0.049}$
Electron	$< 8 \text{ GeV}/c$	0.232 ± 0.013	0.707 ± 0.046
	$> 8 \text{ GeV}/c$	0.330 ± 0.021	$1.000^{+0.000}_{-0.067}$

Sample composition (cont'd)

To estimate dilution by D^{**} , we make use of the B monte carlo sample with full detector simulation.

Sample composition in the monte carlo sample:
(involving $\epsilon(\pi_s^+)$ measured in the data)

Dataset	$p_T(D^0)$	$\ell^- D^0$		$\ell^- D^{*+}$	
	range	N_{B^-}	$N_{\bar{B}^0}$	N_{B^-}	$N_{\bar{B}^0}$
Muon	< 8 GeV/c	2959.4	1032.2	145.1	1051.5
	> 8 GeV/c	2050.1	402.5	148.4	1011.4
Electron	< 8 GeV/c	2176.8	701.1	100.4	823.8
	> 8 GeV/c	1044.4	156.4	61.6	515.0

From this table, we calculate the B^- fraction as,

$$g_- = \frac{N_{B^-}}{N_{\bar{B}^0} \frac{\tau_{\bar{B}^0}}{\tau_{B^-}} + N_{B^-}}$$

Summary of g_- with $\tau(B^-)/\tau(\bar{B}^0) = 1$:

Dataset	$p_T(D^0)$ range	$\ell^- D^0$	$\ell^- D^{*+}$
Muon	< 8 GeV/c	0.741	0.121
	> 8 GeV/c	0.836	0.128
Electron	< 8 GeV/c	0.756	0.109
	> 8 GeV/c	0.870	0.107

Likelihood function for lifetime fit

Likelihood function for the semileptonic B signal:

$$\mathcal{F}_B(ct^*, \sigma_{ct^*}) = \exp\left(-\frac{ct}{c\tau}K\right) \otimes D(K) \otimes G(ct^*; s\sigma_{ct^*})$$

ct^*, σ_{ct^*} ... B pseudo decay time and its resolution,
given event-by-event

$c\tau$... B meson lifetime

$D(K)$... K factor distribution

s ... resolution scale factor

Event likelihood:

$$l_i(ct^*(i), \sigma_{ct^*}(i)) = f_{\text{sig}} \{ (1 - f_c - f_b) \mathcal{F}_{\text{sl}} + f_c \mathcal{F}_c + f_b \mathcal{F}_b \} \\ + (1 - f_{\text{sig}}) \mathcal{F}_{\text{BG}}$$

$$\mathcal{F}_{\text{sl}} = g_- \mathcal{F}_{B^-} + (1 - g_-) \mathcal{F}_{\bar{B}^0}$$

i ... event ID in each sample

f_{sig} ... fraction of $D^0(D^{*+})$ events in signal region

$\mathcal{F}_{\text{BG}}(ct^*)$... combinatorial BG shape (gaus + 4 tails)

$f_c, \mathcal{F}_c(ct^*)$... fraction and shape of charm background

$f_b, \mathcal{F}_b(ct^*)$... fraction and shape of bottom background

g_- ... fraction of B^- in each sample

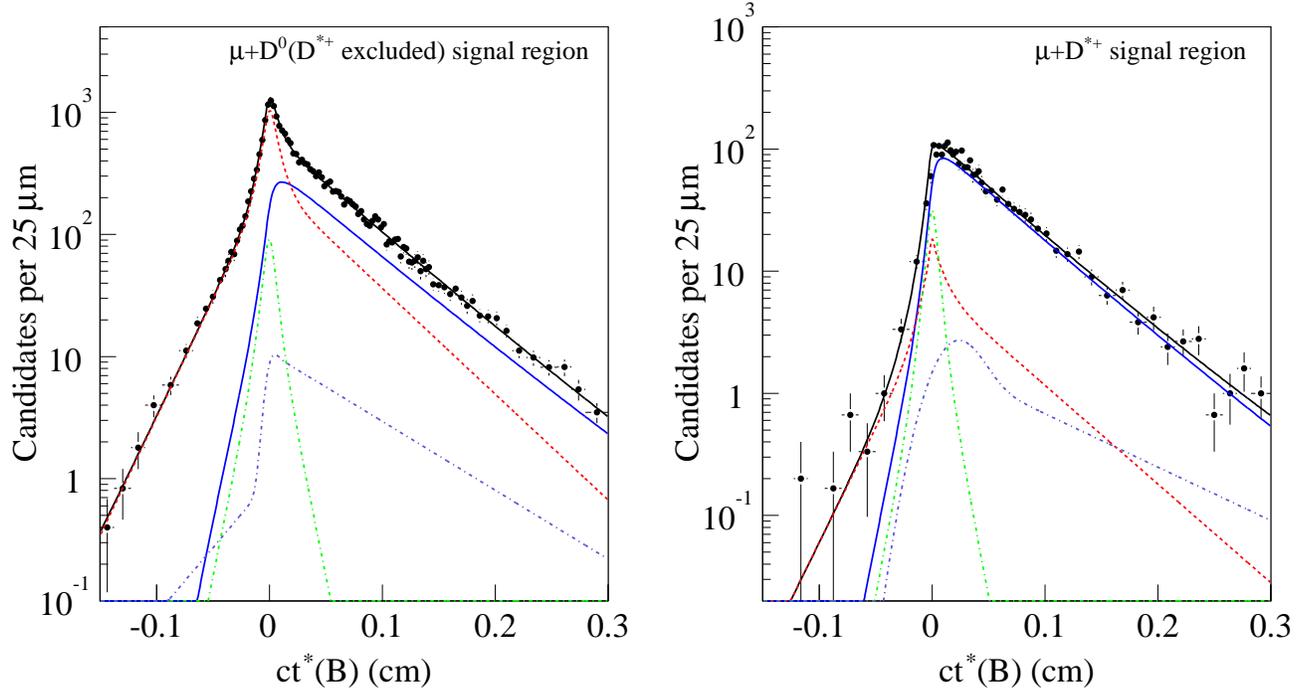
Combined likelihood for each sample:

$$L_X = \prod_i l_i (\mathbf{X} = \mu^- D^0, \mu^- D^{*+}, e^- D^0, e^- D^{*+})$$

Fit results for the muon dataset

First we fit the muon and electron datasets separately.
 Only the $c\tau(B^-)$, $c\tau(\bar{B}^0)$ are floated at the fit.

Fit for muon sample ... maximize $L_\mu = L_{\mu^- D^0} \cdot L_{\mu^- D^{*+}}$



- Points** ... data
- Black** ... $\mathcal{F} = \mathcal{F}_B + \mathcal{F}_{BG} + \mathcal{F}_c + \mathcal{F}_b$
- Blue** ... \mathcal{F}_B
- Red** ... \mathcal{F}_{BG}
- Dashed green** ... \mathcal{F}_c
- Dashed blue** ... \mathcal{F}_b

Fit results for the muon:

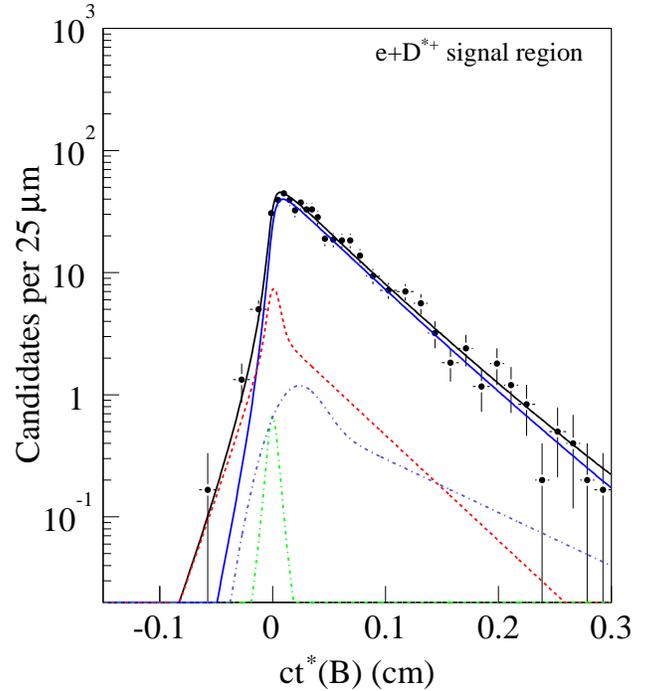
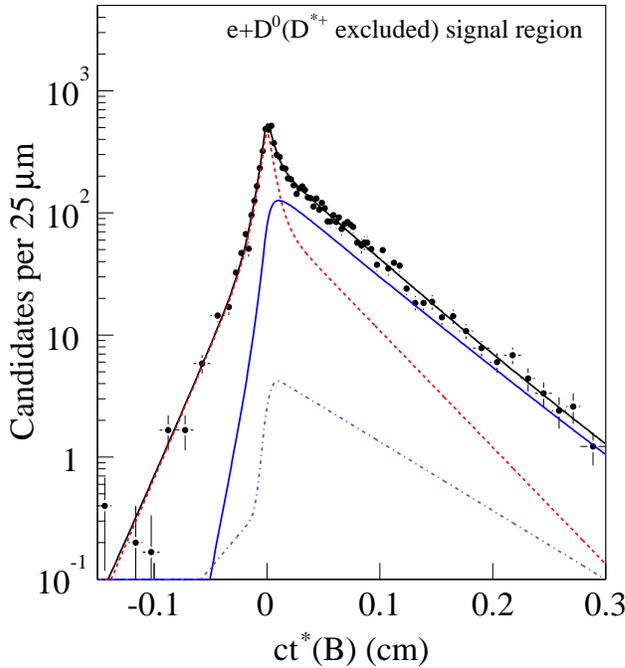
$$c\tau(B^-) = 489.8 \pm 10.8 \mu\text{m}$$

$$c\tau(\bar{B}^0) = 453.6 \pm 13.6 \mu\text{m}$$

$$\tau(B^-)/\tau(\bar{B}^0) = 1.080 \pm 0.048$$

Fit results for the electron dataset

Fit for electron sample ... maximize $L_e = L_{e-D^0} \cdot L_{e-D^{*+}}$



- | | | |
|---------------------|-----|--|
| Points | ... | data |
| Black | ... | $\mathcal{F} = \mathcal{F}_B + \mathcal{F}_{BG} + \mathcal{F}_c + \mathcal{F}_b$ |
| Blue | ... | \mathcal{F}_B |
| Red | ... | \mathcal{F}_{BG} |
| Dashed green | ... | \mathcal{F}_c |
| Dashed blue | ... | \mathcal{F}_b |

Fit results for the electron:

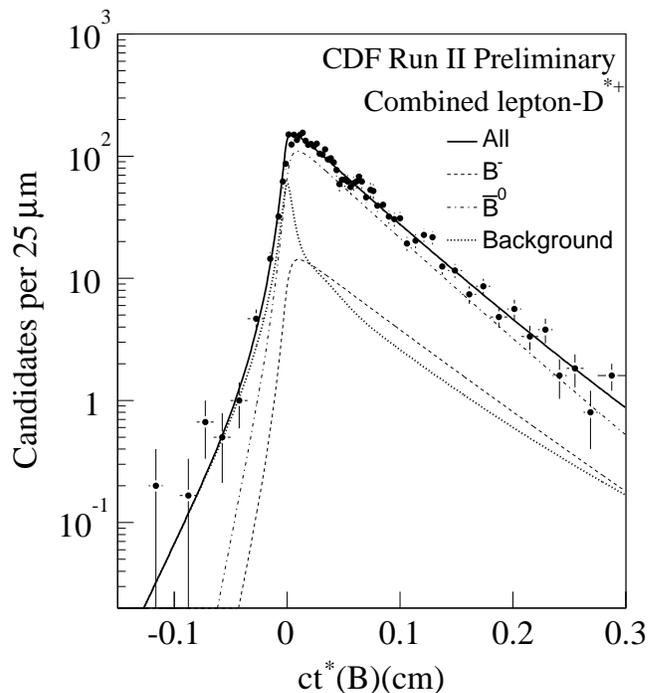
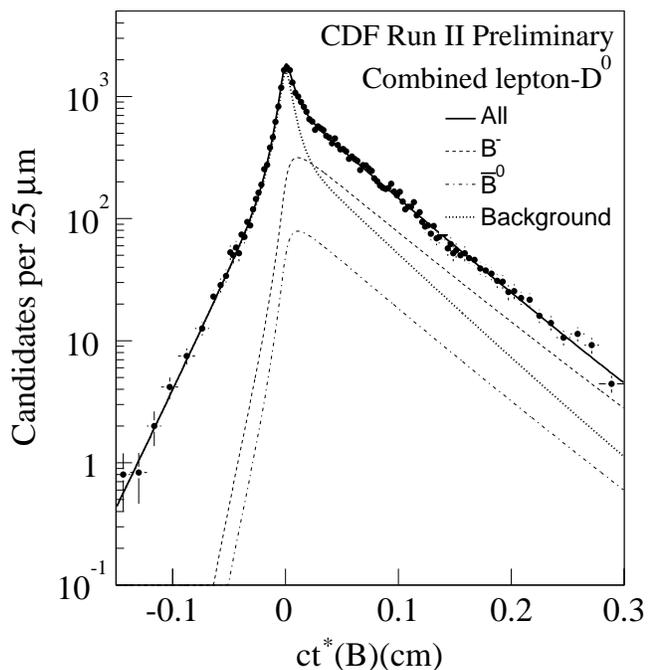
$$c\tau(B^-) = 504.7 \pm 13.9 \mu\text{m}$$

$$c\tau(\bar{B}^0) = 418.1 \pm 18.2 \mu\text{m}$$

$$\tau(B^-)/\tau(\bar{B}^0) = 1.207 \pm 0.072$$

Combined fit result

Maximize $L_{\text{combined}} = L_e \cdot L_\mu$



μ, e combined fit results:

$$c\tau(B^-) = 495.6 \pm 8.6 \mu\text{m}$$

$$c\tau(\bar{B}^0) = 441.5 \pm 10.9 \mu\text{m}$$

$$\tau(B^-)/\tau(\bar{B}^0) = 1.123 \pm 0.040$$

Systematic uncertainties

Source	Contribution to		
	$c\tau(B^-)(\mu\text{m})$	$c\tau(\bar{B}^0)(\mu\text{m})$	$\tau(B^-)/\tau(\bar{B}^0)$
Charm background			
Charm BG fraction (f_c)	+3.7 -1.9	+5.7 -3.7	+0.006 -0.007
Charm BG shape (\mathcal{F}_c)	± 2.6	± 5.2	± 0.007
Bottom background			
Bottom BG fraction (f_b)	+0.3 -0.9	+0.7 -1.5	+0.001 -0.002
Bottom BG shape (\mathcal{F}_b)	± 2.6	± 1.4	± 0.002
Sample composition			
D^{**} fraction (f^{**})	+2.5 -0.6	+6.5 -10.1	+0.032 -0.018
D^{**} composition (P_V)	+0.7 -1.4	+11.0 -8.6	+0.023 -0.031
π_s^+ reconstruction	+0.1 -0.6	+0.8 -0.0	+0.000 -0.004
K factor			
$p_T(B)$ spectrum	± 6.1	± 5.3	-
B decay model	± 1.0	± 1.3	-
Electron cuts	± 2.0	± 1.4	-
Signal fraction (f_{sig})	± 2.4	± 0.9	± 0.003
Resolution scale factor	± 9.5	± 5.3	± 0.008
Decay length cut	+0.0 -1.8	+0.0 -2.2	+0.001 -0.000
Combinatorial BG shape	± 0.7	± 0.1	± 0.002
Detector alignment	± 2.0	± 2.0	-
Total	+13.3 -12.8	+17.0 -17.0	+0.041 -0.039

Total systematic uncertainties are order of 3-4%.

Summary

We have measured the B^- and \bar{B}^0 meson lifetimes using semileptonic decays with 8 GeV single lepton datasets.

The lifetimes are found to be

$$c\tau(B^-) = 495.6 \pm 8.6 \begin{matrix} +13.3 \\ -12.8 \end{matrix} \mu\text{m}$$

$$c\tau(\bar{B}^0) = 441.5 \pm 10.9 \pm 17.0 \mu\text{m}$$

or

$$\tau(B^-) = 1.653 \pm 0.029 \begin{matrix} +0.044 \\ -0.043 \end{matrix} \text{ps}$$

$$\tau(\bar{B}^0) = 1.473 \pm 0.036 \pm 0.057 \text{ps}$$

And we find the lifetime ratio to be

$$\tau(B^-)/\tau(\bar{B}^0) = 1.123 \pm 0.040 \begin{matrix} +0.041 \\ -0.039 \end{matrix}$$

where the first and second uncertainties are statistical and systematic respectively.

These results are consistent with following current world average values.

World average values (by HFAG in 2004 summer)

$$c\tau(B^-) = 495.6 \pm 4.2 \mu\text{m}$$

$$c\tau(\bar{B}^0) = 459.9 \pm 3.9 \mu\text{m}$$

$$\tau(B^-)/\tau(\bar{B}^0) = 1.081 \pm 0.015$$

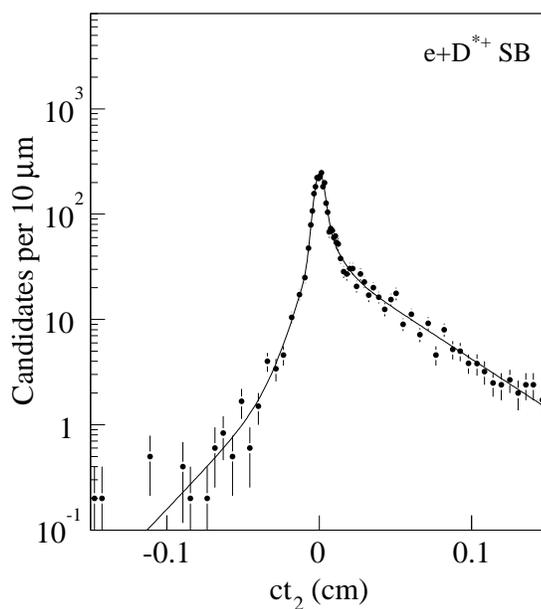
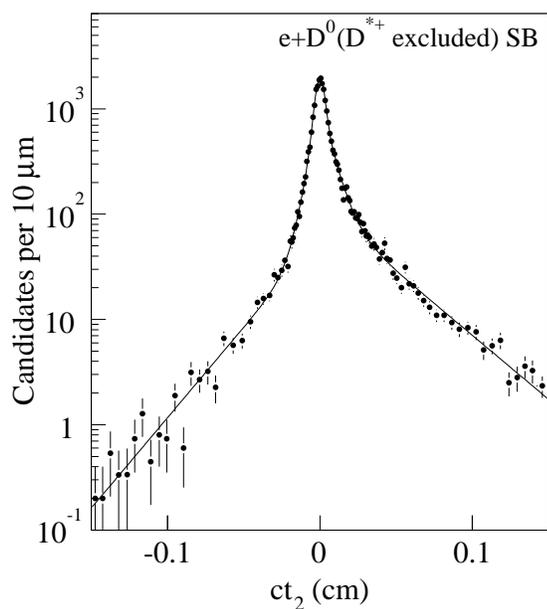
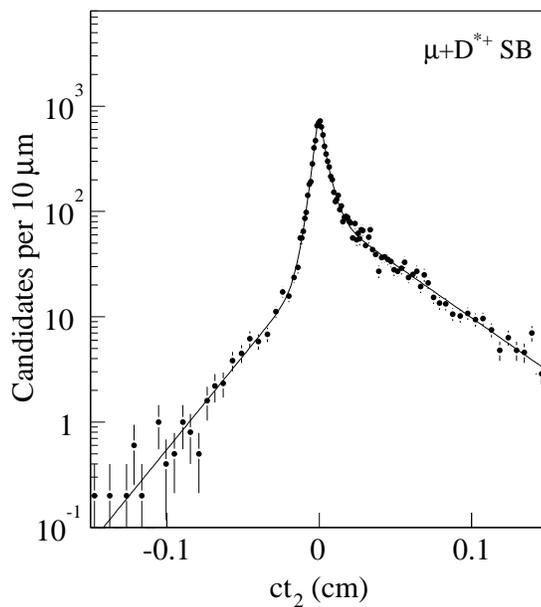
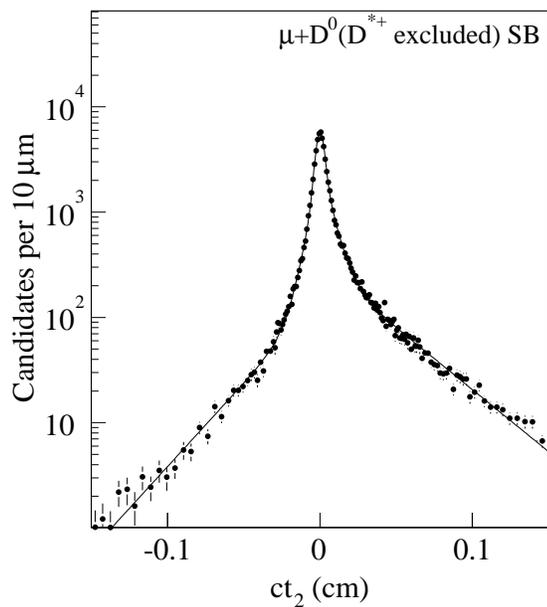
Brief history of lifetime fit results

- Production 4.8.4, $\sim 90 \text{ pb}^{-1}$ 8 GeV muon data
no separation of D^0 and D^{*+}
 $c\tau(B) = 440 \pm 10 \mu\text{m}$ (short lifetime era)
- Production 5.3.1, 260 pb^{-1}
New beamline, new refitting procedure, tighten some cuts
 $c\tau(B) = 455 \pm 6 \mu\text{m}$ (no D^0/D^{*+} separation)
 $c\tau(B^-) = 469 \pm 10 \mu\text{m}$
 $c\tau(\bar{B}^0) = 438 \pm 13 \mu\text{m}$
- Tuning on Monte Carlo (correct $p_T(B)$ spectrum)
 $c\tau(B^-) = 475 \pm 11 \mu\text{m}$
 $c\tau(\bar{B}^0) = 443 \pm 13 \mu\text{m}$
- Subtract prompt charm background
 $c\tau(B^-) = 489 \pm 11 \mu\text{m}$
 $c\tau(\bar{B}^0) = 467 \pm 14 \mu\text{m}$
- Subtract bottom background (current result for muon)
 $c\tau(B^-) = 490 \pm 11 \mu\text{m}$
 $c\tau(\bar{B}^0) = 454 \pm 14 \mu\text{m}$
- Combine electron data
 $c\tau(B^-) = 496 \pm 9 \mu\text{m}$
 $c\tau(\bar{B}^0) = 442 \pm 11 \mu\text{m}$

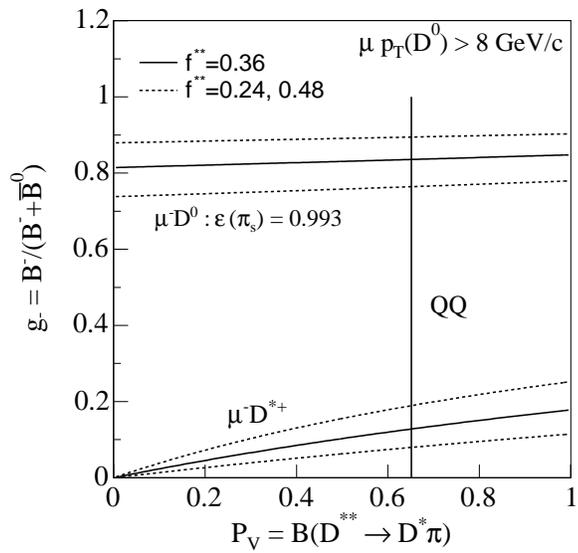
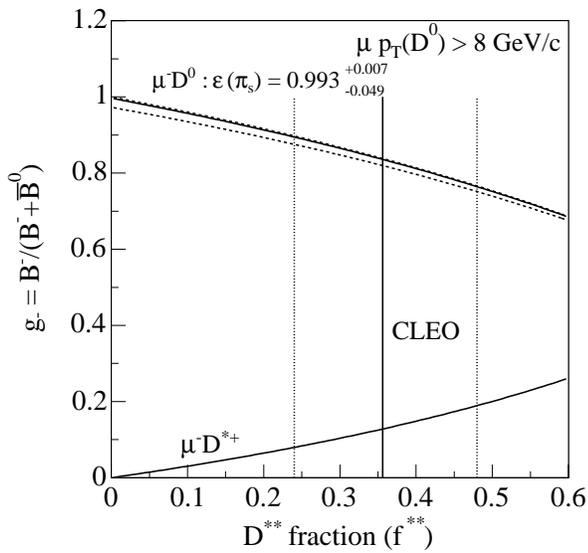
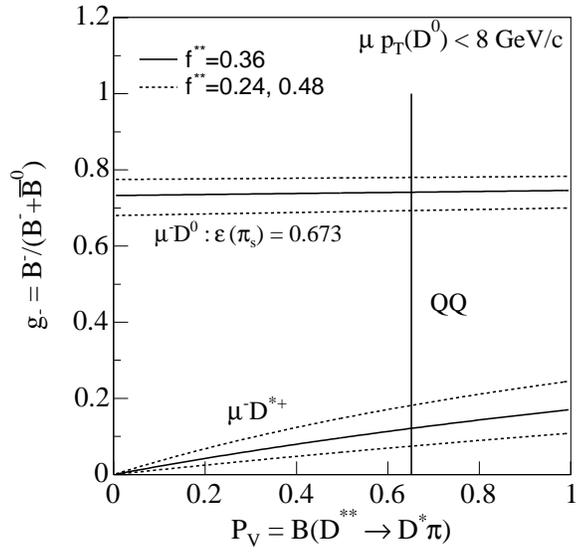
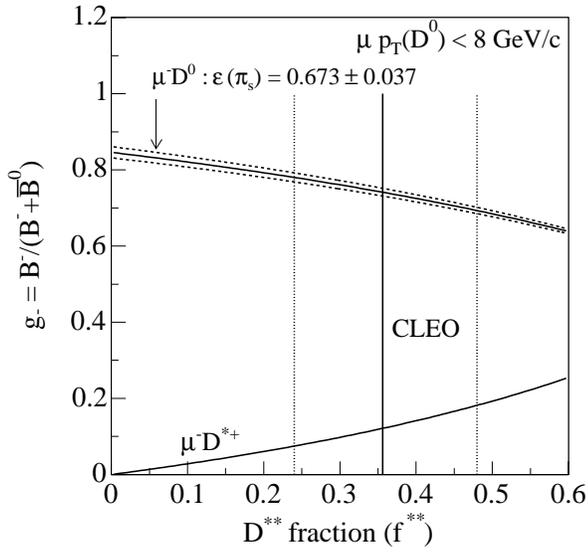
As a brief conclusion, prompt charm background gives a major contribution to the short lifetime.

Backup slides

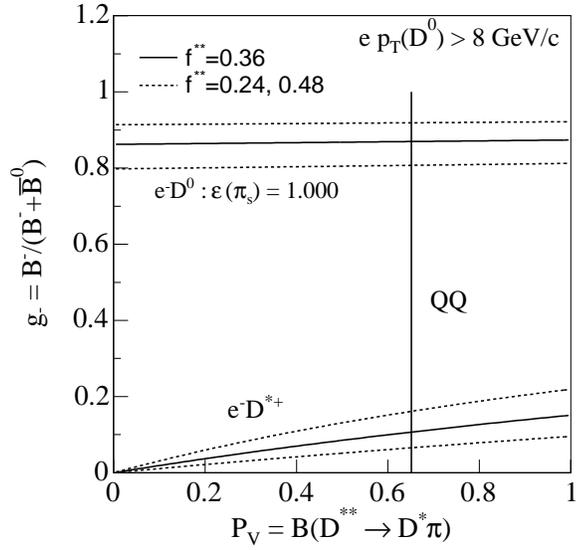
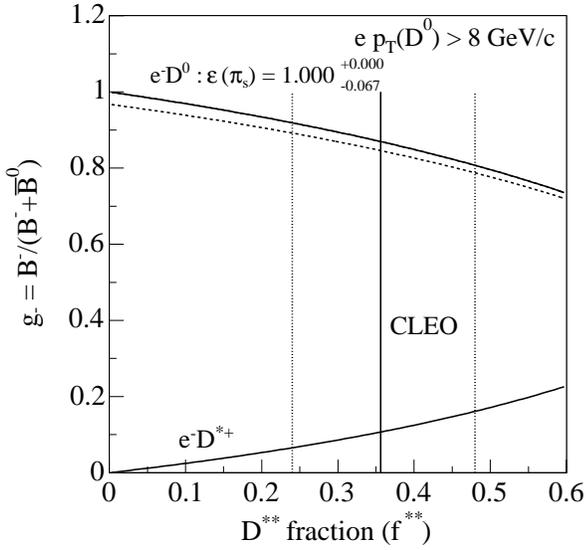
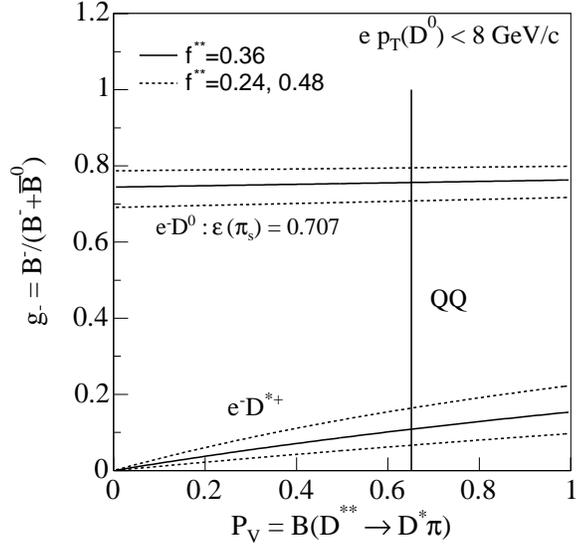
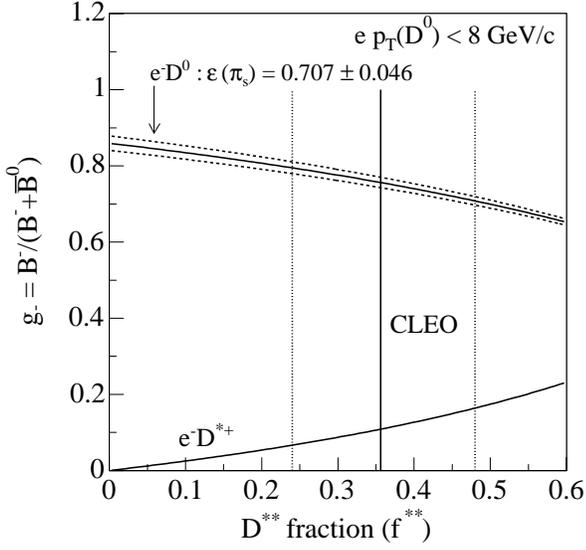
Background shapes for ct_2



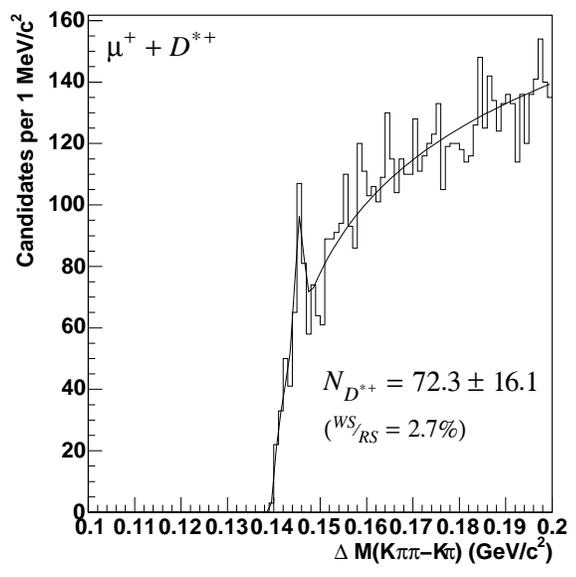
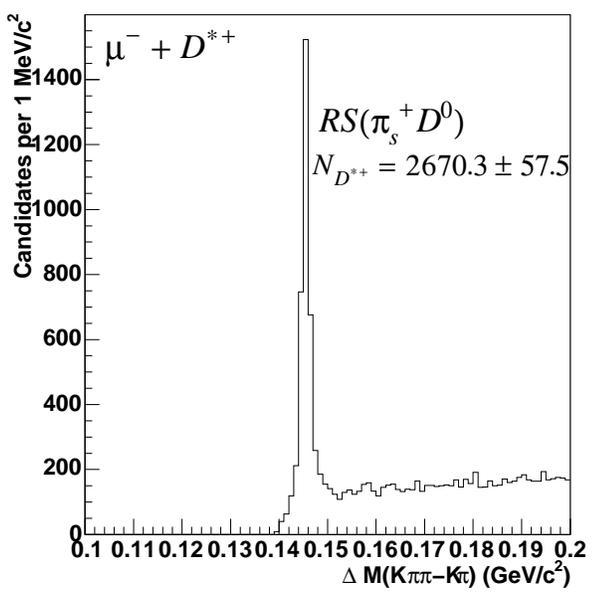
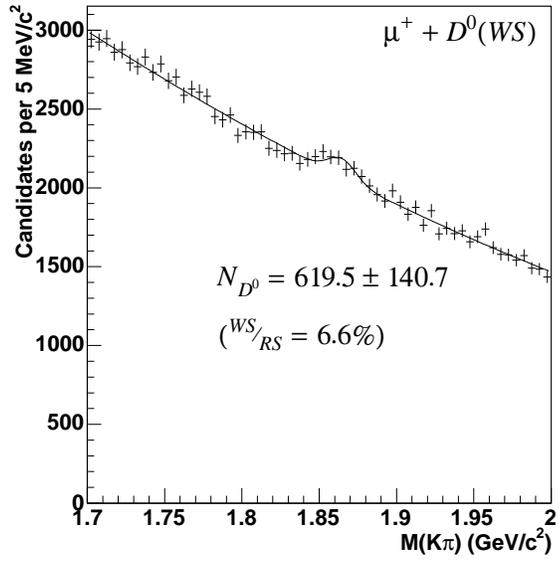
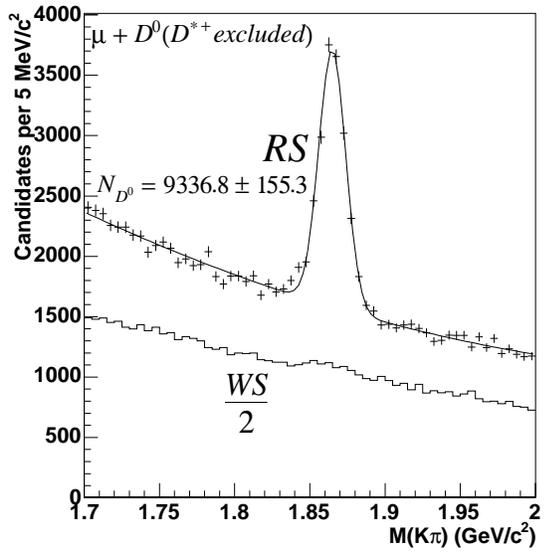
g_- changes as function of f^{} and P_V , for muon**



g_- changes as function of f^{**} and P_V , for electron



WS peak in wrong-sign μD^0 and μD^{*+}



ct^* shape of WS events

ct^* distributions for WS events, signal-SB plots:

